STEALTH™ Dual Diode 30 A, 600 V

ISL9K1560G3

ON Semiconductor®

www.onsemi.com

Description

The ISL9K1560G3 is a STEALTH dual diode optimized for low loss performance in high frequency hard switched applications. The STEALTH family exhibits low reverse recovery current (I_{RR}) and exceptionally soft recovery under typical operating conditions.

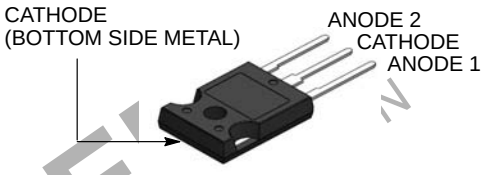
This device is intended for use as a free wheeling or boost diode in power supplies and other power switching applications. The low I_{RR} and short ta phase reduce loss in switching transistors. The soft recovery minimizes ringing, expanding the range of conditions under which the diode may be operated without the use of additional snubber circuitry. Consider using the STEALTH diode with an SMPS IGBT to provide the most efficient and highest power density design at lower cost.

Features

- Stealth Recovery t_{rr} = 29.4 ns (@ I_F = 15 A)
- Max Forward Voltage, V_F = 2.2 V (@ T_C = 25°C)
- 600 V Reverse Voltage and High Reliability
- Avalanche Energy Rated
- This Device is Pb−Free and is RoHS Compliant

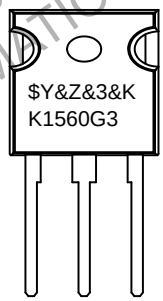
Applications

- Switch Mode Power Supplies
- Hard Switched PFC Boost Diode
- UPS Free Wheeling Diode
- Motor Drive FWD
- SMPS FWD
- Snubber Diode

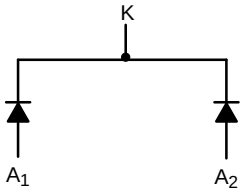


TO−247−3LD
CASE 340CK

MARKING DIAGRAM



$Y	= ON Semiconductor Logo
&Z	= Assembly Plant Code
&3	= Numeric Date Code
&K	= Lot Code
K1560G3	= Specific Device Code



ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

DEVICE MAXIMUM RATINGS (per leg) (T_C = 25°C unless otherwise noted)

Parameter	Symbol	Ratings	Unit
Repetitive Peak Reverse Voltage	V_{RRM}	600	V
Working Peak Reverse Voltage	V_{RWM}	600	V
DC Blocking Voltage	V_R	600	V
Average Rectified Forward Current (T_C = 145°C) Total Device Current (Both Legs)	$I_{F(AV)}$	15 30	A A
Repetitive Peak Surge Current (20 kHz Square Wave)	I_{FRM}	30	A
Nonrepetitive Peak Surge Current (Halfwave 1 Phase 60 Hz)	I_{FSM}	200	A
Power Dissipation	P_D	150	W
Avalanche Energy (1 A, 40 mH)	E_{AVL}	20	mJ
Operating and Storage Temperature Range	T_J, T_{STG}	−55 to +175	°C
Maximum Temperature for Soldering Leads at 0.063 in (1.6 mm) from Case for 10 s Package Body for 10 s, See Techbrief TB334	T_L T_{PKG}	300 260	°C °C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

PACKAGE MARKING AND ORDERING INFORMATION

Device	Device Marking	Package	Packing Method	Tape Width	Quantity
ISL9K1560G3	K1560G3	TO−247−3L	Tube	N/A	30

THERMAL CHARACTERISTICS

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Thermal Resistance Junction to Case	$R_{\theta JC}$		−	−	1.0	°C/W
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	TO−247	−	−	30	°C/W

ELECTRICAL CHARACTERISTICS (per leg) (T_C = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions		Min	Typ	Max	Unit
OFF STATE CHARACTERISTICS							
Instantaneous Reverse Current	I_R	V_R = 600 V	T_C = 25°C	–	–	100	μA
			T_C = 125°C	–	–	1.0	mA
ON STATE CHARACTERISTICs							
Instantaneous Forward Voltage	V_F	I_F = 15 A	T_C = 25°C	–	1.8	2.2	V
			T_C = 125°C	–	1.65	2.0	V
DYNAMIC CHARACTERISTICS							
Junction Capacitance	C_J	V_R = 10 V, I_F = 0 A		–	62	–	pF
SWITCHING CHARACTERISTICS							
Reverse Recovery Time	t_{rr}	I_F = 1 A, dI/dt = 100 A/μs, V_R = 30 V		–	25	30	ns
		I_F = 15 A, dI/dt = 100 A/μs, V_R = 30 V		–	35	40	ns
Reverse Recovery Time	t_{rr}	I_F = 15 A, dI_F/dt = 200 A/μs, V_R = 390 V, T_C = 25°C		–	29.4	–	ns
Reverse Recovery Current	I_{rr}			–	3.5	–	A
Reverse Recovered Charge	Q_{rr}			–	57	–	nC
Reverse Recovery Time	t_{rr}	I_F = 15 A, dI_F/dt = 200 A/μs, V_R = 390 V, T_C = 125°C		–	90	–	ns
Softness Factor (t_b/t_a)	S			–	2.0	–	
Reverse Recovery Current	I_{RR}			–	5.0	–	A
Reverse Recovered Charge	Q_{RR}			–	275	–	nC
Reverse Recovery Time	t_{rr}	I_F = 15 A, dI_F/dt = 800 A/μs, V_R = 390 V, T_C = 125°C		–	52	–	ns
Softness Factor (t_b/t_a)	S			–	1.36	–	
Reverse Recovery Current	I_{RR}			–	13.5	–	A
Reverse Recovered Charge	Q_{RR}			–	390	–	nC
Maximum di/dt during t_b	dI_M/dt			–	800	–	A/μs

TYPICAL PERFORMANCE CURVES

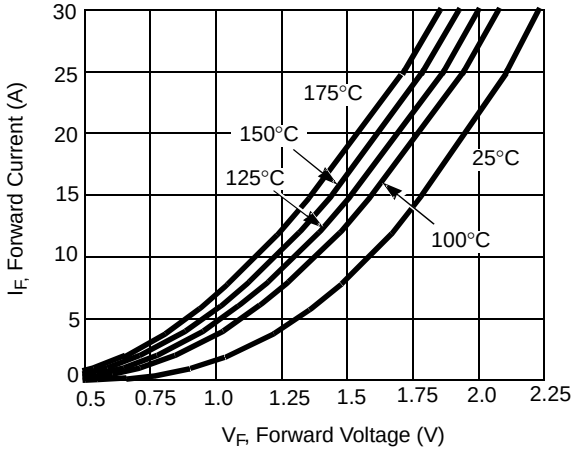


Figure 1. Forward Current vs. Forward Voltage

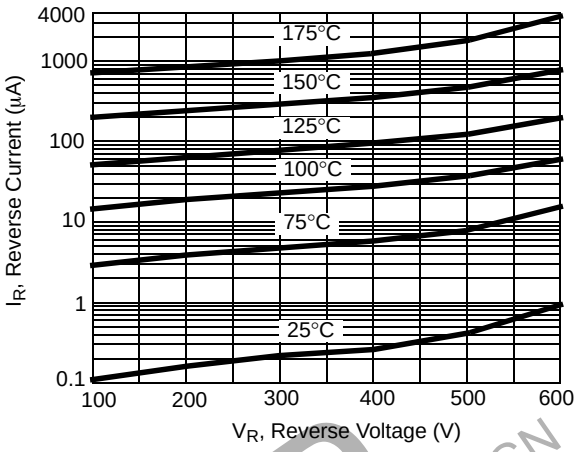


Figure 2. Reverse Current vs. Reverse Voltage

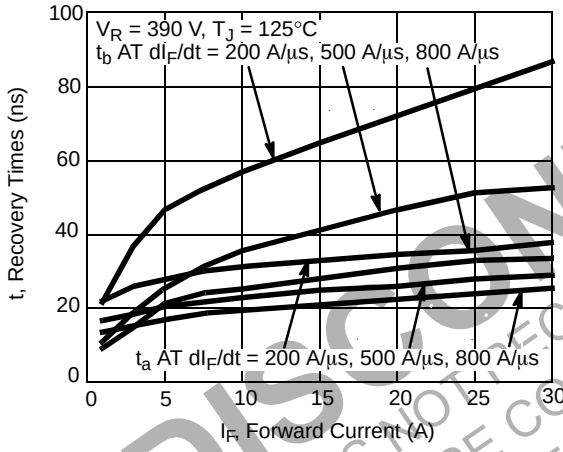


Figure 3. t_a and t_b Curves vs. Forward Current

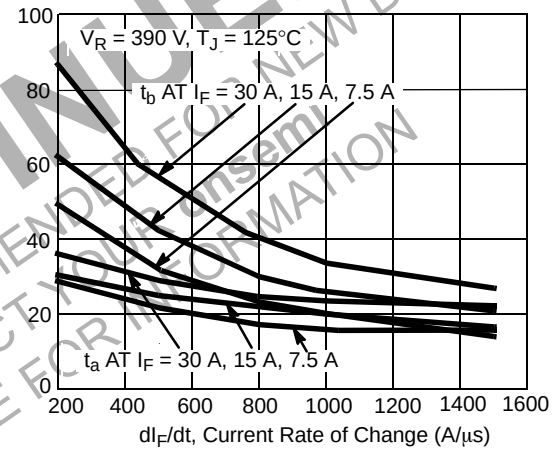


Figure 4. t_a and t_b Curves vs. dI_F/dt

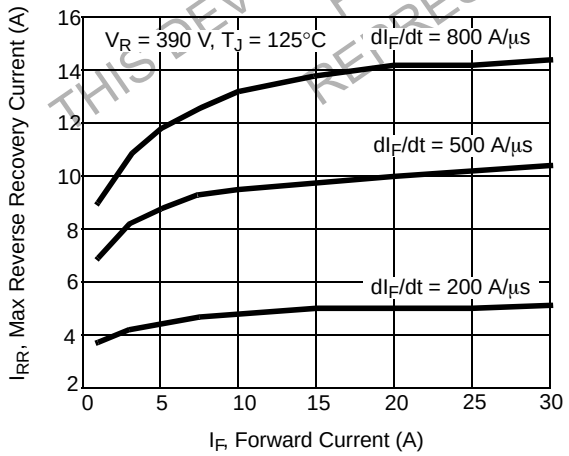


Figure 5. Maximum Reverse Recovery Current vs. Forward Current

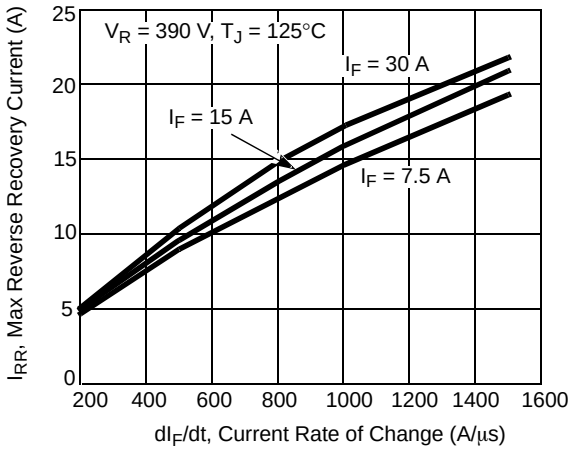


Figure 6. Maximum Reverse Recovery Current vs. dI_F/dt

TYPICAL PERFORMANCE CURVES (continued)

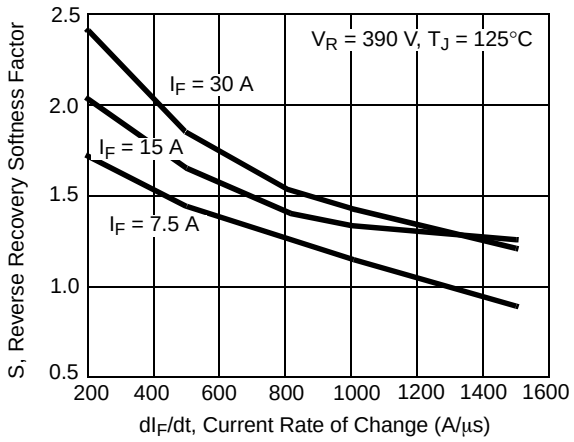


Figure 7. Reverse Recovery Softness Factor vs. dI_F/dt

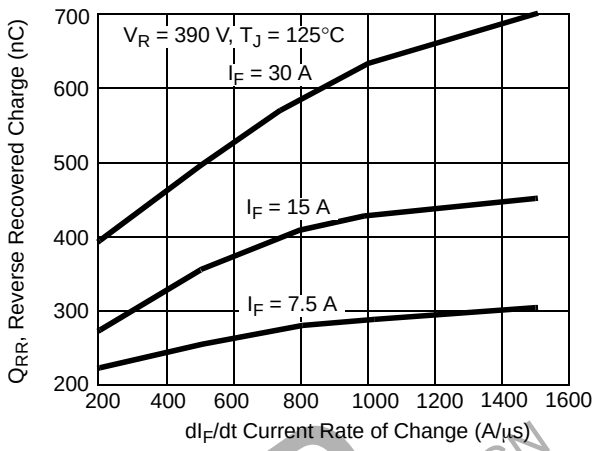


Figure 8. Reverse Recovered Charge vs. dI_F/dt

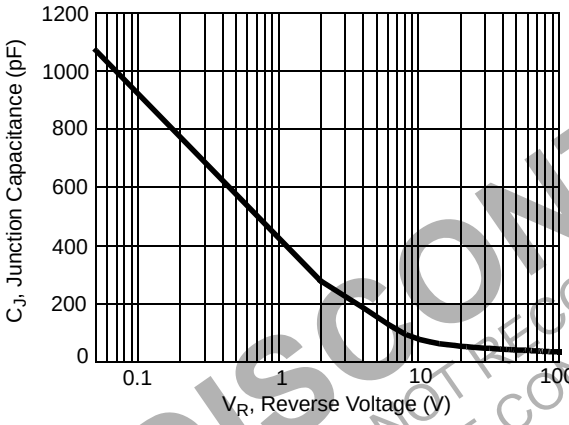


Figure 9. Junction Capacitance vs. Reverse Voltage

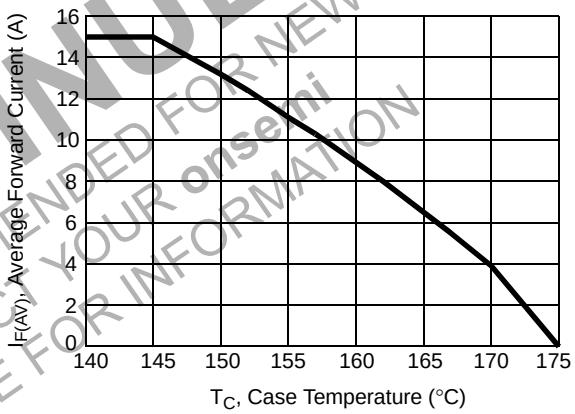


Figure 10. DC Current Derating Curve

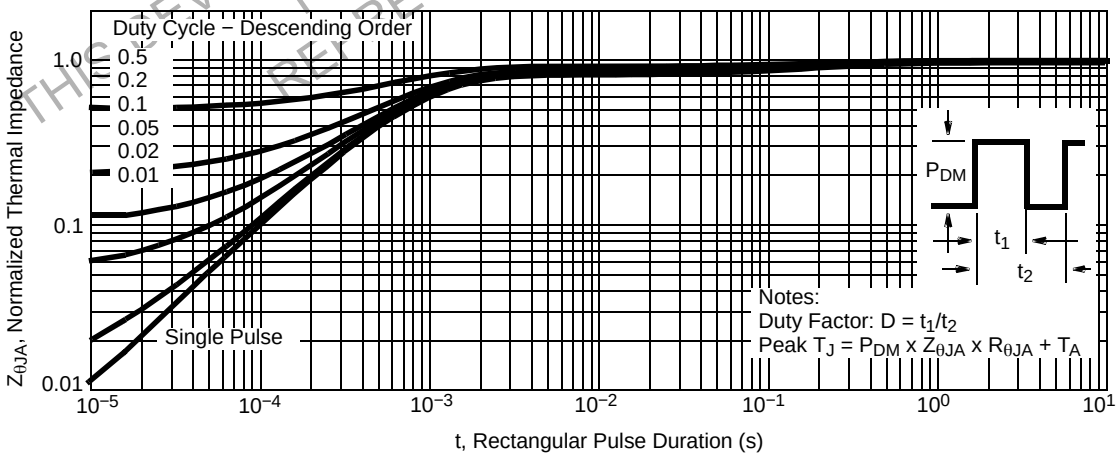


Figure 11. Normalized Maximum Transient Thermal Impedance

TEST CIRCUIT AND WAVEFORMS

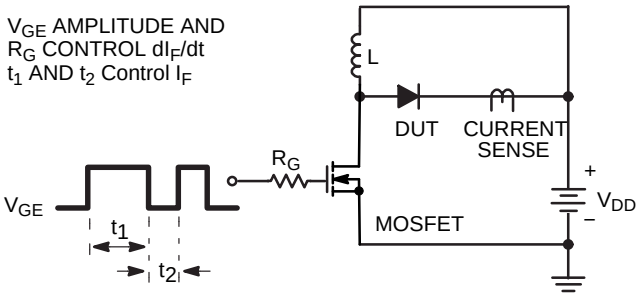


Figure 12. t_{rr} Test Circuit

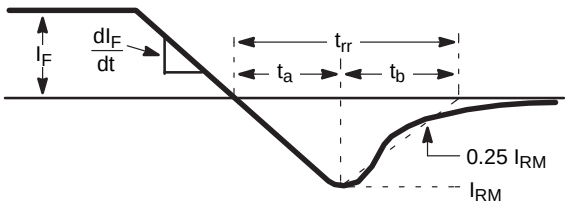


Figure 13. t_{rr} Waveforms and Definitions

I = 1 A
L = 40 mH
R < 0.1 Ω
V_{DD} = 50 V
$E_{AVL} = 1/2LI^2 [V_{R(AVL)}/(V_{R(AVL)} - V_{DD})]$
Q_1 = IGBT (BV_{CES} > DUT $V_{R(AVL)}$)

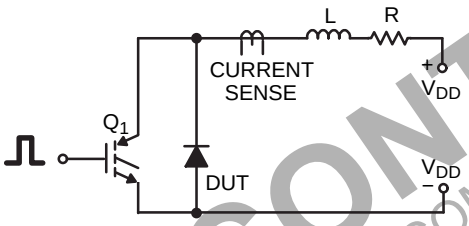


Figure 14. Avalanche Energy Test Circuit

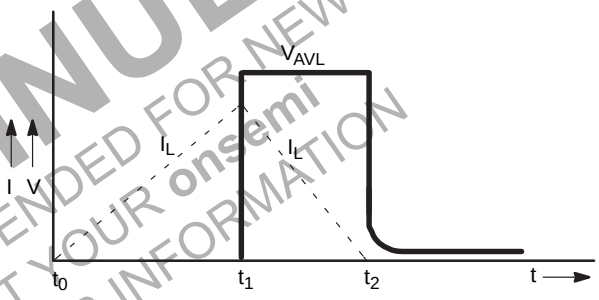


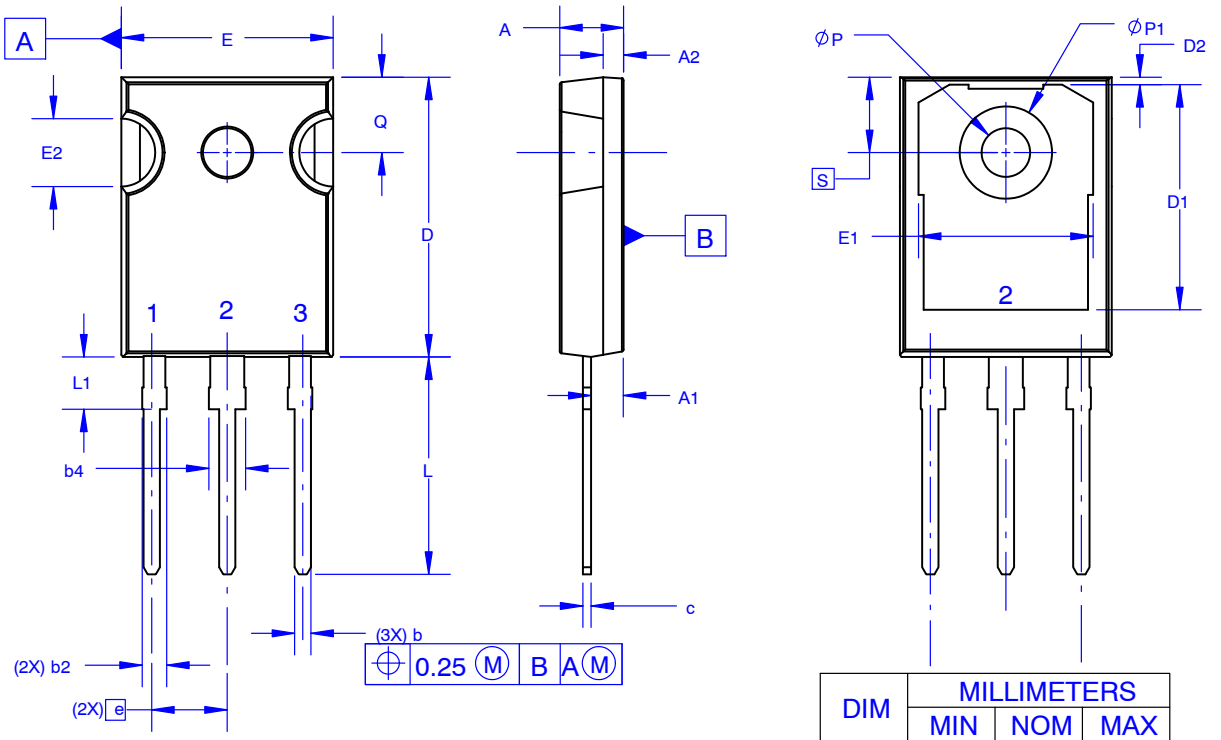
Figure 15. Avalanche Current and Voltage Waveforms

MECHANICAL CASE OUTLINE
PACKAGE DIMENSIONS

ON Semiconductor®

TO−247−3LD SHORT LEAD
CASE 340CK
ISSUE A

DATE 31 JAN 2019

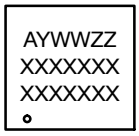


DIM	MILLIMETERS		
	MIN	NOM	MAX
A	4.58	4.70	4.82
A1	2.20	2.40	2.60
A2	1.40	1.50	1.60
b	1.17	1.26	1.35
b2	1.53	1.65	1.77
b4	2.42	2.54	2.66
c	0.51	0.61	0.71
D	20.32	20.57	20.82
D1	13.08	~	~
D2	0.51	0.93	1.35
E	15.37	15.62	15.87
E1	12.81	~	~
E2	4.96	5.08	5.20
e	~	5.56	~
L	15.75	16.00	16.25
L1	3.69	3.81	3.93
ØP	3.51	3.58	3.65
ØP1	6.60	6.80	7.00
Q	5.34	5.46	5.58
S	5.34	5.46	5.58

NOTES: UNLESS OTHERWISE SPECIFIED.

A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
B. ALL DIMENSIONS ARE IN MILLIMETERS.
C. DRAWING CONFORMS TO ASME Y14.5 - 2009.
D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC
MARKING DIAGRAM*



XXXX = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
ZZ = Assembly Lot Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, “G” or microdot “▪”, may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	**TO−247−3LD SHORT LEAD**	**PAGE 1 OF 1**

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